

Dual N-Channel Enhancement Mode MOSFET

DESCRIPTION

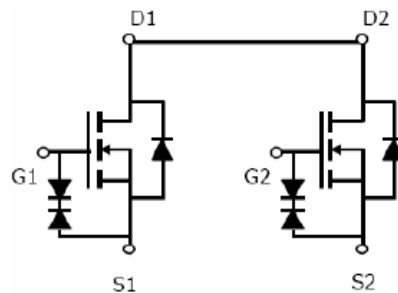
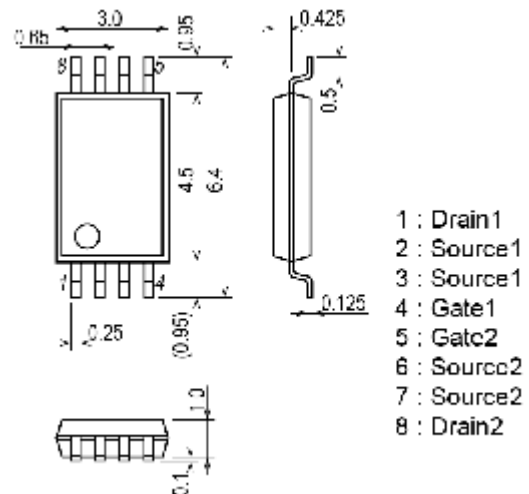
The UC1870 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. These device are particularly suited for use as a load switch or in PWM application. It is ESD protected.

GENERAL FEATURES

- $V_{DS}=20V, I_D=7A$
 - $R_{DS(ON)}=16m\Omega(\text{typ}) @ V_{GS}=4.5V$
 - $R_{DS(ON)}=20m\Omega(\text{typ}) @ V_{GS}=2.5V$
 - $R_{DS(ON)}=28m\Omega(\text{typ}) @ V_{GS}=1.8V$
- Low ON-resistance
- Lead free product is acquired
- Surface Mount Package
- ESD Rating: 2000V HBM

Application

- Battery protection
- Load switch
- Potable Equipment



PACKAGE MARKING AND ORDERING INFORMATION

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|--------|----------------|-----------|------------|----------|
| A1870 | UC1870 | TSSOP8 | 330mm | 12mm | 3000 |

Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$ Unless Otherwise Noted)

| Parameter | Symbol | Limit | Unit |
|---|----------|----------|--------------------|
| Drain-Source Voltage | V_{DS} | 20 | V |
| Gate-Source Voltage | V_{GS} | ± 12 | V |
| Drain Current-Continuous | I_D | 7 | A |
| Drain Current-Continuous @Current-Pulsed(Note 1) | I_{DM} | 30 | A |
| Maximum Power Dissipations (25°C) | P_D | 1.48 | W |
| Maximum Junction Temperature | T_J | 150 | $^{\circ}\text{C}$ |

THERMAL CHARACTERISTICS

| | | | |
|--|-----------------|------|-----------------------------|
| Thermal Resistance, Junction-to-Ambient(Note2) | $R_{\theta JA}$ | 83.3 | $^{\circ}\text{C}/\text{W}$ |
|--|-----------------|------|-----------------------------|

Electrical Characteristics ($T_A=25^{\circ}\text{C}$ Unless Otherwise Noted)

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|-----------------------------------|--------------|---|------|---------|----------|------------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0\text{V}, I_D=250\mu\text{A}$ | 20 | | | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=18\text{V}, V_{GS}=0\text{V}$ | | | 1 | μA |
| Gate-Body Leakage Current | I_{GSS} | $V_{GS}=\pm 10\text{V}, V_{DS}=0\text{V}$ | | ± 3 | ± 10 | μA |
| ON CHARACTERISTICS(Note 3) | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 0.55 | 0.7 | 1 | V |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS}=4.5\text{V}, I_D=6\text{A}$ | | 16 | 19 | $\text{m}\Omega$ |
| | | $V_{GS}=2.5\text{V}, I_D=5.2\text{A}$ | | 20 | 24 | |
| | | $V_{GS}=1.8\text{V}, I_D=5\text{A}$ | | 28 | 32 | |
| Forward Transconductance | g_{FS} | $V_{DS}=5\text{V}, I_D=4.5\text{A}$ | 4.5 | | | S |

Electrical Characteristics (Cont.) ($T_A=25^{\circ}\text{C}$ Unless Otherwise Noted)

| DYNAMIC CHARACTERISTICS(Note 4) | | | | | | |
|------------------------------------|---------------------|--|-----|------|-----|------|
| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
| Input Capacitance | C _{ISS} | V _{DS} =10V, V _{GS} =0V, F=1.0MHz | | 1300 | | PF |
| Output Capacitance | C _{OSS} | | | 190 | | PF |
| Reverse Transfer Capacitance | C _{RSS} | | | 154 | | PF |
| SWITCHING CHARACTERISTICS(Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =10V, V _{GS} =4.5V, R _{GEN} =3Ω, R _L =1.35Ω | | 7 | | ns |
| Turn-on Rise Time | t _r | | | 15 | | ns |
| Turn-off Delay Time | t _{d(off)} | | | 53 | | ns |
| Turn-off Fall Time | t _f | | | 17 | | ns |
| Total Gate Charge | Q _g | V _{DS} =10V, I _D =6A, V _{GS} =4.5V | | 23 | | nc |
| Gate-Source Charge | Q _{gs} | | | 2 | | nc |
| Gate-Drain Charge | Q _{gd} | | | 3.4 | | nc |
| DRAIN-SOURCE DIODE CHARACTERISTICS | | | | | | |
| Diode Forward Voltage(Note 3) | V _{SD} | V _{GS} =0V, I _S =1.7A | | 0.8 | 1.3 | V |
| Diode Forward Current(Note 2) | I _S | | | | 7 | A |

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
4. Guaranteed by design, not subject to production testing.

Typical Characteristics

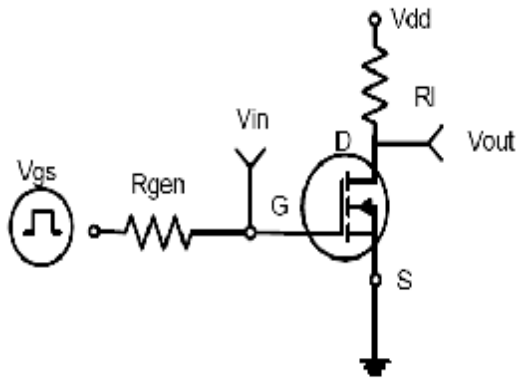


Figure 1: Switching Tset Circuit

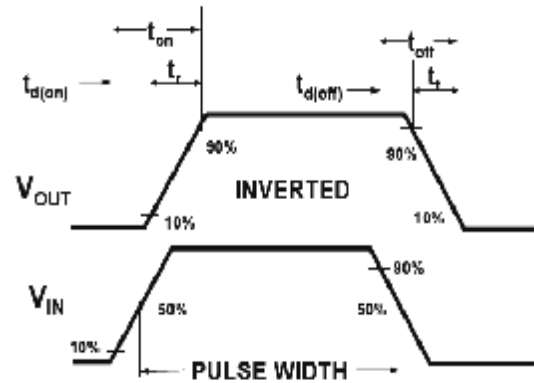


Figure 2: Switching Waveforms

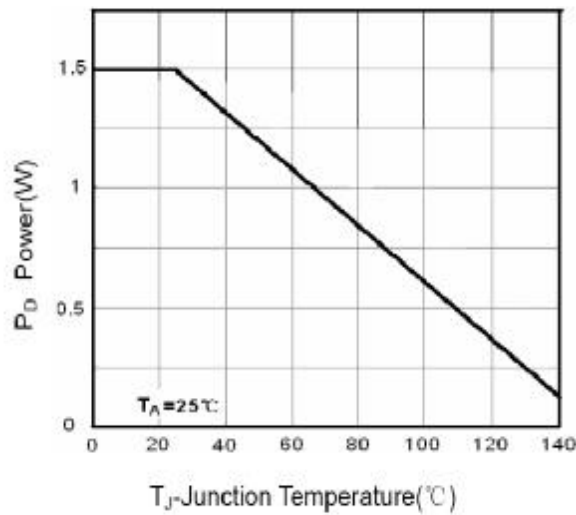


Figure 3: Power Dissipation

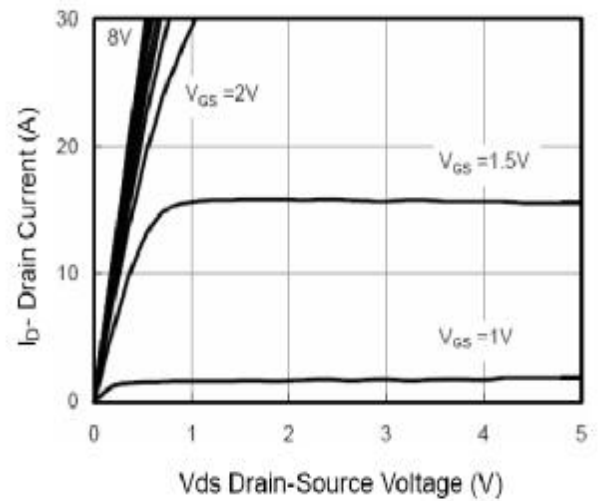


Figure 4: Output Characteristics

Typical Characteristics

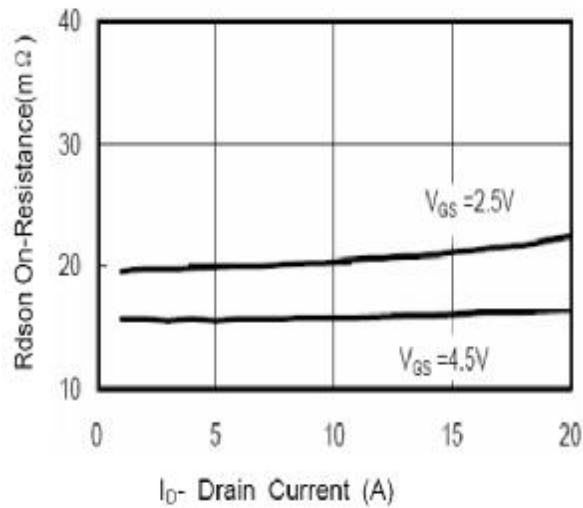


Figure 5: Drain-Source On-Resistance

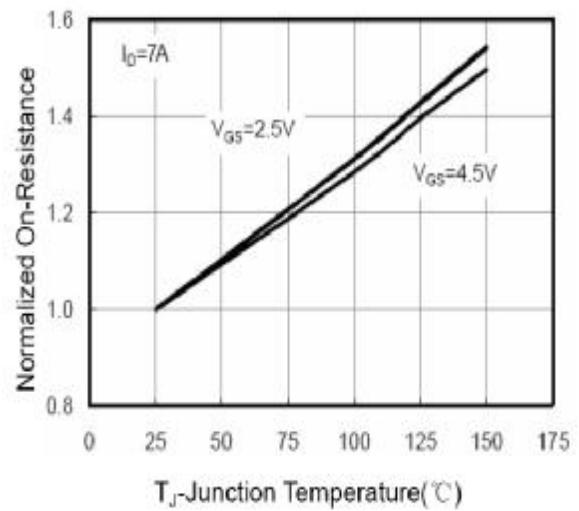


Figure 6: Drain-Source On-Resistance

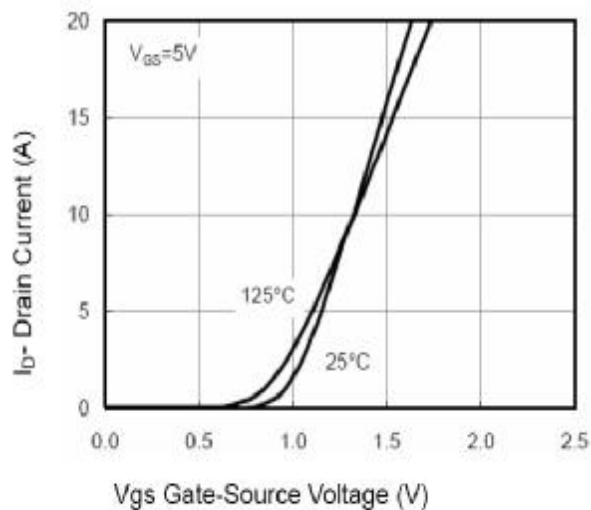


Figure 7: Transfer Characteristics

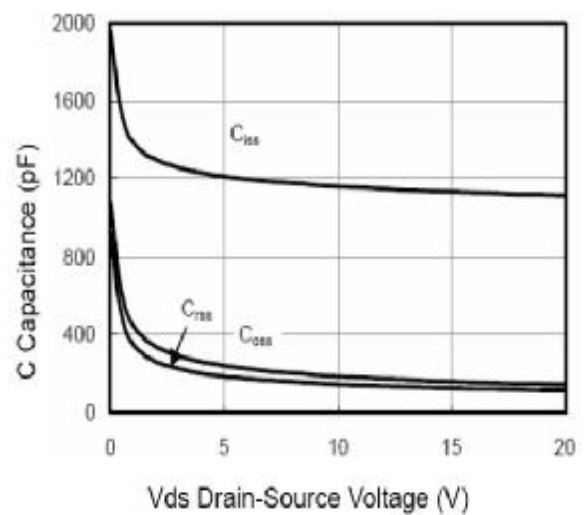


Figure 8: Capacitance vs V_{DS}

Typical Characteristics

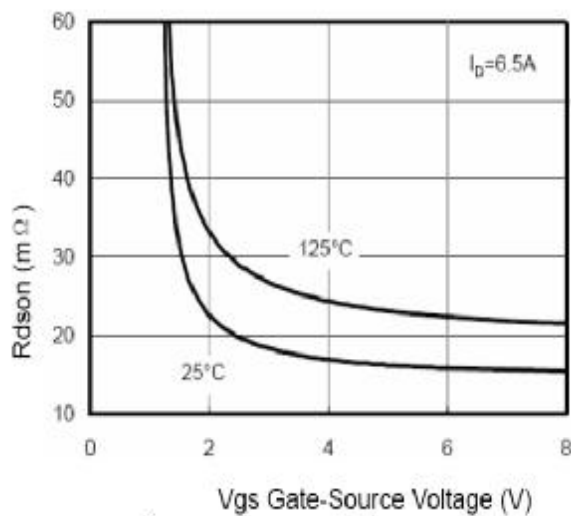


Figure 9: Rdson vs Vgs

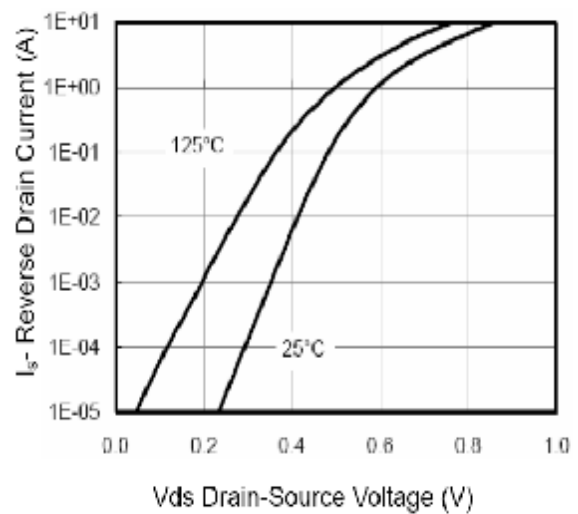


Figure 10: Reverse Drain Current VS Vds

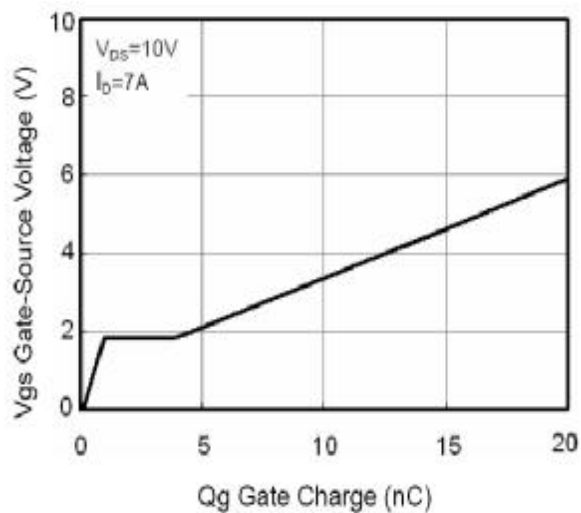


Figure 11: Gate Charge

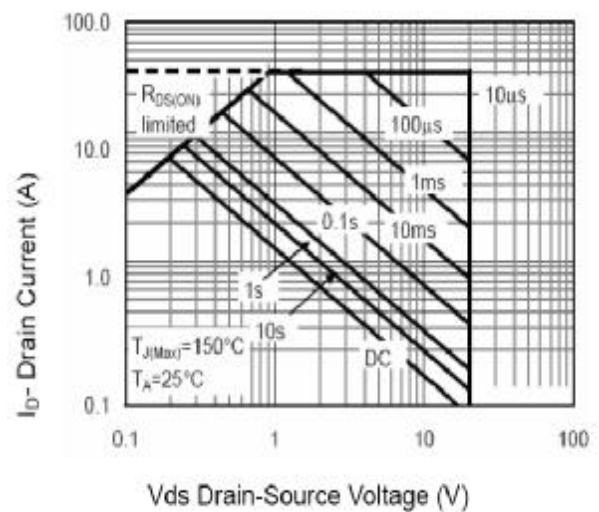


Figure 12: Safe Operation Area



Typical Characteristics

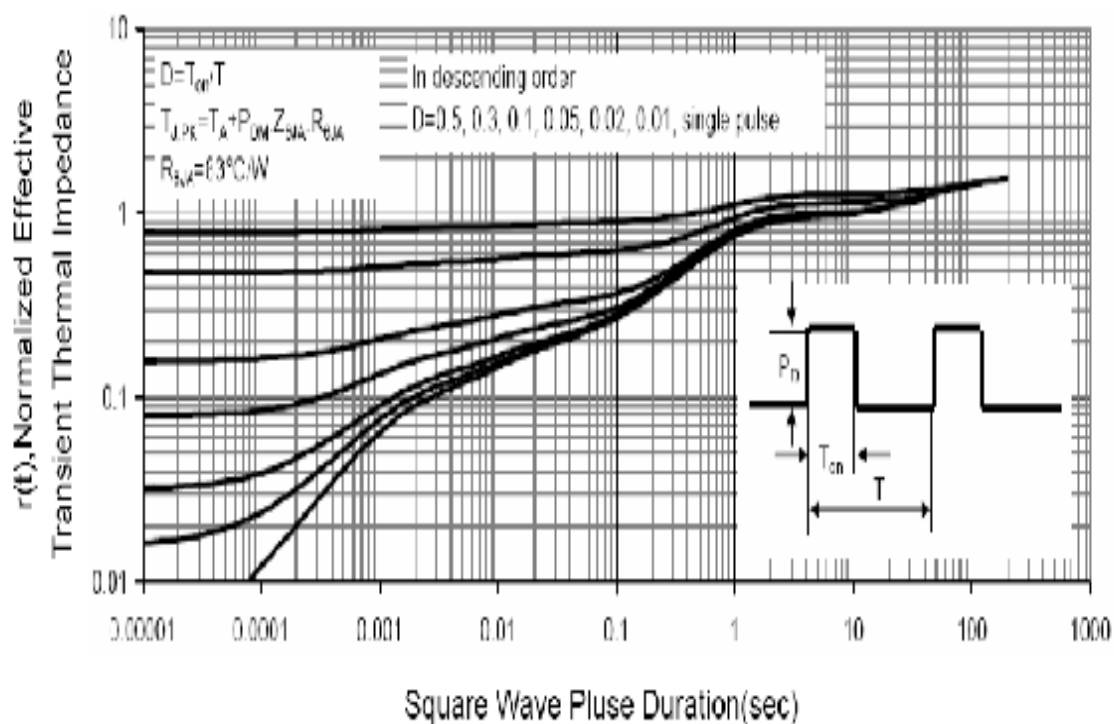
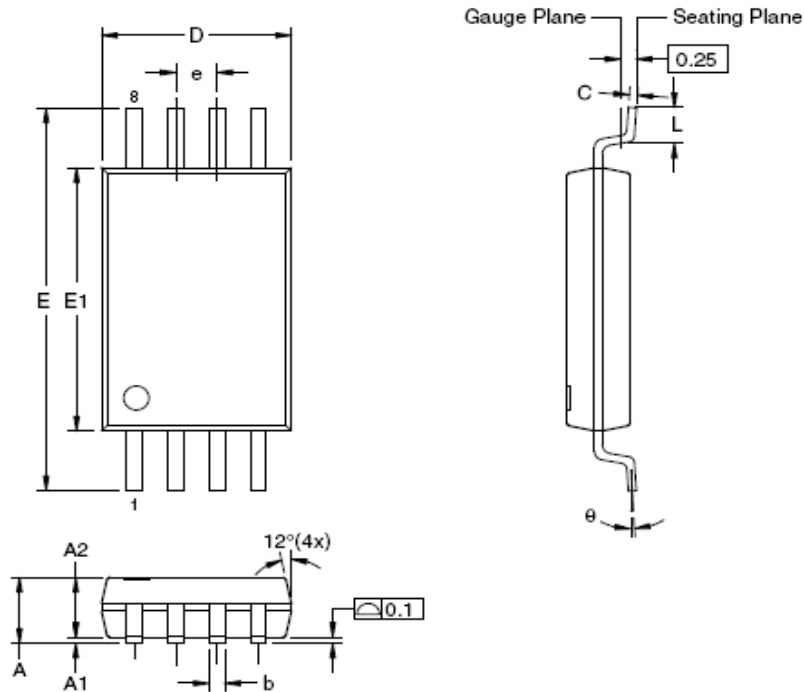
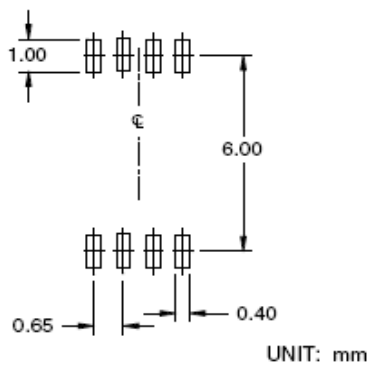


Figure 13: Normalized Maximum Transient Thermal Impedance

Package Information



RECOMMENDED LAND PATTERN



Dimensions in millimeters

| Symbols | Min. | Nom. | Max. |
|---------|----------|------|------|
| A | — | — | 1.20 |
| A1 | 0.05 | — | 0.15 |
| A2 | 0.80 | 1.00 | 1.05 |
| b | 0.19 | — | 0.30 |
| C | 0.09 | — | 0.20 |
| D | 2.90 | 3.00 | 3.10 |
| E | 6.40 BSC | | |
| E1 | 4.30 | 4.40 | 4.50 |
| e | 0.65 BSC | | |
| L | 0.45 | 0.60 | 0.75 |
| θ | 0° | — | 8° |

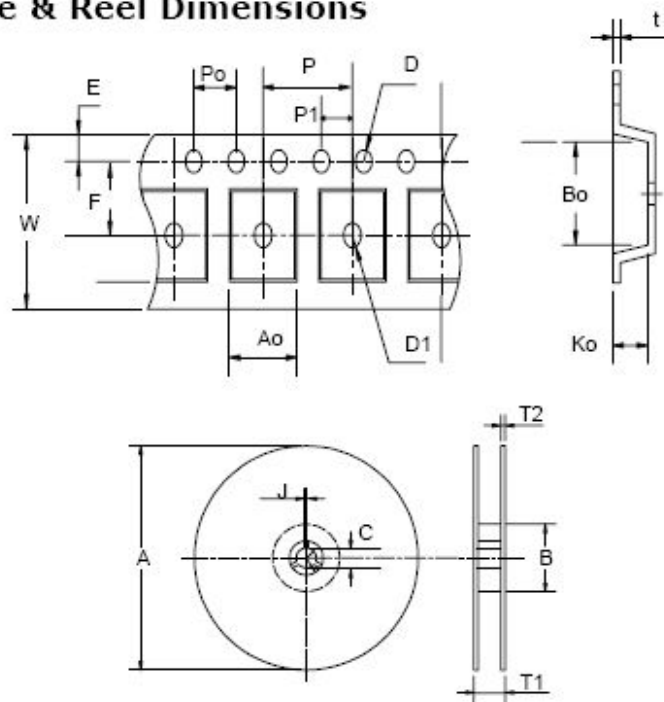
Dimensions in inches

| Symbols | Min. | Nom. | Max. |
|---------|-----------|-------|-------|
| A | — | — | 0.047 |
| A1 | 0.002 | — | 0.006 |
| A2 | 0.031 | 0.039 | 0.041 |
| b | 0.007 | — | 0.012 |
| C | 0.004 | — | 0.008 |
| D | 0.114 | 0.118 | 0.122 |
| E | 0.252 BSC | | |
| E1 | 0.169 | 0.173 | 0.177 |
| e | 0.026 BSC | | |
| L | 0.018 | 0.024 | 0.030 |
| θ | 0° | — | 8° |

Notes:

1. All dimensions are in millimeters.
2. Dimensions are inclusive of plating
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.
6. Refer to JEDEC MO-153(AA).

Carrier Tape & Reel Dimensions



| Application | A | B | C | J | T1 | T2 | W | P | E |
|-------------|-----------|-----------|--------------|-----------|------------|-----------|-----------|-----------|-------------|
| TSSOP-8 | 330 ± 1 | 62 ± 1.5 | 12.75 ± 0.13 | 2 ± 0.5 | 12.4 ± 0.2 | 2 ± 0.2 | 12 ± 0.3 | 8 ± 0.1 | 1.75 ± 0.1 |
| | F | D | D1 | P0 | P1 | A0 | B0 | K0 | t |
| | 5.5 ± 0.1 | 1.5 ± 0.1 | 1.5 ± 0.1 | 4.0 ± 0.1 | 2.0 ± 0.1 | 7.0 ± 0.1 | 3.6 ± 0.3 | 1.6 ± 0.1 | 0.3 ± 0.013 |

Reliability test program

| Test item | Method | Description |
|---------------|---------------------|---------------------------|
| SOLDERABILITY | MIL-STD-883D-2003 | 245°C, 5 SEC |
| HOLT | MIL-STD 883D-1005.7 | 1000 Hrs Bias @ 125°C |
| PCT | JESD-22-B, A102 | 168 Hrs, 100% RH, 121°C |
| TST | MIL-STD 883D-1011.9 | -65°C ~ 150°C, 200 Cycles |

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